



Silicon Wafer Europe TC Chapter

SEMICON Europe Standards Meetings

Thursday, Nov 12, 2026

09:00 AM - 11:00 AM CET

ICM/Office Staffelsee

AGENDA

1.0 Welcome / Call to Order

- 1.1 Introductions
- 1.2 Meeting Reminders (*Membership Requirement, Antitrust and Intellectual Property Reminders, Effective Meeting Guidelines*)
- 1.3 Agenda Review

2.0 Review and Approval of Previous Meeting Minutes

3.0 Liaison Report

- 3.1 Japan Committee
- 3.2 North America

4.0 Staff Report

5.0 Ballot Review

6.0 Task Force Reports

- 6.1 Int'l Advanced Wafer Geometry Task Force /F. Riedel/F. Passek
- 6.2 Int'l Automated Advanced Surface Inspection Task Force/ J. Wittmann
- 6.3 Int'l Polished Wafer Task Force/ C. Sanna
- 6.4 Int'l Test Methods TF/T. Hager

7.0 Old Business

8.0 New Business

9.0 Action Item Review

- 9.1 Open Action Items
- 9.2 New Action Items

10.0 Next Meeting and Adjournment